Se	arcn Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/618,374	NARUI ET AL.	
Examiner	Art Unit	
Eugene Lee	2815	

	SEARCHED		
Class	Subclass	Date	Examiner
257	228,215	6/16/2006	EL
257	237-239	6/16/2006	EL
438	75	6/16/2006	EL
257	246	6/16/2006	EL
257	e27.082	6/16/2006	EL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	228,215	6/16/2006	EL
257	237-239	6/16/2006	EL
257	246	6/16/2006	EL
257/e27.082; 438/75		6/16/2006	EL

SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	)
	DATE	EXMR
searched EAST, USPAT, JPO EPO	6/16/2006	EL